

Test Plan Reference

PLT

0.6.9

2020-03-30

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Revision History

Revision History

Revision 0.6.9 2020-03-30

- Remove ESP32_HomeKit target
- program: Allow any number of firmware elements
- program: Add PN7360, PN7362, PN7460 and PN7462 targets
- serial set: Set serial number
- pin: Can control SWD_NRST and UARTx_RTS

Revision 0.6.8 2020-02-24

New commands:

- canCfg Configure CAN interface
- canClear Configure CAN interface
- canMatch Match received CAN message
- canSend Send CAN message
- ftdiCfg Configure external FTDI

Revision 0.6.5 2019-10-07

• Add STM32F2 and ST32F2_STLink targets

Revision 0.6.4 2019-10-08

No change

Revision 0.6.3 2019-10-07

- document `noflush` option for uart and uartExpect commands
- eval command
- uart: extract multiple keys
- ble test: Low-level BLE testing

Revision 0.6.2 2019-10-03

- document JLink/ST-Link target variants
- update initial example
- scan: ANY format
- serial request: user key extraction

Revision 0.5.7 2019-08-22 • `label` command: Document ZPL templates • add Nordic nRF91 Cortex-M33 targets Revision 0.5.6 2019-08-19 • Document retry mechanism for test items and test item steps • Document GATT-level BLE commands • Document 'image' command test step to set background images • Document setting Label substitutions with the 'label' command test step • add AVRATmega168P/PB targets Revision 0.5.2 2019-05-13 • `measure`: Document `reference` argument Document `nfc` command Revision 0.5.1 2019-04-16 • Add `CC1352` target • Document 'define' command Revision 0.5.0 2019-03-31 • Document `freq` command • Document 'measure' command • Document `mux` command • Document 'pin' command • Document 'power' command • Document `short` command • Document `uartCfg` command Revision 0.4.9 2019-03-28 • Document `serial request` command • Update UART port names Revision 0.4.8 2019-03-08 Renamed to Test Plan Reference Revision 0.4.7 2019-03-08 Split off from System Manual

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Preface

Document describing the test suite definition for use with the Production Line Tool.

1. Test Plan Reference

1.1 Test Plan YAML definition

Example: A minimal test suite, with a single test item, scanning a bar code.

```
title: "PLT demo: Scan"
suite:
- ident: SCAN-T1
   title: Scan MAC address
   steps:
- command: scan ANY
```

1.1.1 Test Plan Structure

PLT test suites are encoded as YAML text files, starting with the test suite title.

```
title: "PLT demo: Scan"
```

The title: is followed by the suite: section, containing the test items in the test plan.

1.1.1.1 Test Items

Test items are identified with an **ident**: line, can contain a descriptive **title**, and should contain one or more test item steps.

During test execution, all test item steps need to complete successfully for the test item to succeed.

1.1.1.2 Test Item Steps

Test item steps consist of command: or uartcmd: blocks. A Test Item can contain multiple Test Item steps.

1.1.1.3 Retries

Retry counts can be set for at the test item of test item step level, by adding a retry: field.

```
title: "Retries"
suite:
- ident: T1
  title: Test Item retries
  retry: 3
  steps:
  - command: sleepms 1000
  - command: operator Manual
- ident: T2
  title: Test Item retries
  steps:
  - command: sleepms 1000
  - command: operator Manual
  retry: 3
```

1.1.2 Basic Example

A basic In-Circuit Test suite for the PLT demo board.

```
title: "v0.1.8 (Green)"
suite:
- ident: ICT-T1
  title: Identify DUT
  steps:
- command: identify nRF52
- ident: ICT-T2
  title: Erase nRF52
  steps:
```

- command: erase nRF52

- ident: ICT-T3
 title: Program DEMO-BOARD FW nRF52

steps:

- command: program nRF52 s132_nrf52_6.0.0_softdevice.hex,ly10-demo-fw-0.1.8.hex

- ident: ICT-T4

title: BLE discovery

steps:

- command: bledis %BLEMAC% 30 # Wait up to 30 seconds for BLE discovery to complete

1.2 Test Commands

1.2.1 ble gatt - GATT-level BLE Tests

Perform GATT-level BLE interactions with the DUT.

Usage:

```
ble gatt connect addr:<address> [<timeout> [<minRSSI>]]
ble gatt connect name:<name> [<timeout> [<minRSSI>]]
ble gatt disconnect
ble gatt discover
ble gatt match char:<charUUID> <matchHex>
ble gatt read char:<charUUID> <matchHex>
ble gatt sub char:<charUUID>
ble gatt write char:<charUUID> <valueHex>
```

Argument	Description	
name	GAP name advertised by DUT.	
address	BLE MAC address used by the DUT.	
timeout	Timeout, in seconds	
minRSSI	RSSI treshold (optional)	
connect	Connect to GATT peripheral	
disconnect	Disconnect from GATT peripheral	
discover	Discover GATT services and characteristics	
match	Match a value for a subscribed characteristic	
read	Read a GATT characteristic	
sub	Subscribe to notifications from a GATT characteristic	
write	Write to a GATT characteristic	

Example: Validate BLE Device Information Service

```
title: "DIS Validation"
suite:
- ident: ICT-T1
  title: Identify DUT
  steps:

    command: identify nRF52

- ident: ICT-T2
  title: Program LY10-DEMO-BOARD FW
  steps:
  - command: program nRF52 s132_nrf52_6.0.0_softdevice.hex,ly10-demo-fw-0.1.7.hex
 ident: ICT-T3
  title: Validate BLE DIS
  steps:
  - command: ble gatt connect addr: %ble_mac% 10
  - command: ble gatt discover
 # GAP: Device Name
  - command: ble gatt read char: 2a00 4c5931302d44454d4f5f424f415244 # "LY10-DEMO BOARD"
 # GAP Appearance
  - command: ble gatt read char:2a01 0000
 # GAP:Peripheral Preferred Connection Parameters
  - command: ble gatt read char: 2a04 0600080200009001
 # GAP:Central Address Resolution
  - command: ble gatt read char:2aa6 01
 # DIS:Manufacturer Name String
  - command: ble gatt read char:2a29 424344 # "BCD"
 # DIS:Model Number String
  - command: ble gatt read char:2a24 4c5931302d44454d4f5f424f415244 # "LY10-DEMO_BOARD"
 # DIS:Hardware Revision String
  - command: ble gatt read char:2a27 32303139 # "2019"
 # DIS:Firmware Revision String
  - command: ble gatt read char:2a26 302e312e37 # "0.1.7"
 # DIS:Software Revision String
  - command: ble gatt read char:2a28 312e322e33 # "1.2.3"
  - command: ble gatt disconnect
```

1.2.2 ble test - Low-level BLE Tests

Perform Low-level BLE tests.

Usage:

```
ble test recv <channel>
ble test xmit <channel> [<length> [<payload>]]
ble test stop
```

Argument	Description
channel	BLE channel
length	Test packet payload length
payload	Test packet payload type

1.2.3 bledis - Test BLE Discovery

Establishes a BLE connection to the DUT and discovers GATT services.

Usage:

bledis %BLEMAC%|<name> [<timeout> [<minRSSI>]]

Argument	Description
name	GAP name advertised by DUT. %BLEMAC % to specify the DUT's BLE MAC address instead
timeout	Timeout, in seconds
minRSSI	RSSI treshold (optional)

Example: BLE discovery of identified BLE HW MAC address.

- ident: ICT-T1

title: Identify DUT

steps:

- command: identify nRF52

- ident: ICT-T2

title: BLE Discovery

steps:

- command: bledis %BLEMAC% 30 -60

1.2.4 canCfg - Configure CAN interface

Configure the PLT CAN interface speed.

Usage:

canCfg <port> <bitrate>

Argument	Description	
port	PLT CAN interface; currently only CAN0 is available.	
bitrate	CAN bit rate, in bits per second.	

1.2.5 canClear - Configure CAN interface

Clear the buffer of received CAN frames.

Usage:

canClear <port>

Argument	Description	
port	PLT CAN interface; currently only CANO is available.	

1.2.6 canMatch - Match received CAN message

Test if a particular CAN message has been received.

Usage:

canMatch <port> <msgId> [...]

Argument	Description
port	PLT CAN interface; currently only CANO is available.
msgld	CAN Message Arbitration ID
b	Payload bytes

1.2.7 canSend - Send CAN message

Send a CAN data frame.

Usage:

canSend <port> <msgId> [<b ...]

Argument	Description
port	PLT CAN interface; currently only CANO is available.
msgld	CAN Message Arbitration ID
b	Payload bytes

1.2.8 define - Define user key

Manually defines a test plan key, which will be emedded in the test report and serial number requests performed as part of the current test plan.

Usage:

define <key> <value>

Argument	Description	
key	Name of the test plan key.	
value	Value for the key; can be any kind of string value.	

- ident: ICT-T0

title: Set variables

steps:

- command: define work_order 1011X02

- ident: ICT-T1

title: Request serial

steps:

- command: request serial

1.2.9 erase - Erase DUT Flash

Erase DUT MCU on-board flash.

Usage:

erase <target> [UART0|UART1]

Argument	Description
target	Target to erase
UARTO, UART1	Port for UART targets

Supported target values:

target	Description
AVRATmega168P_ISP	Atmel AVR ATmega168P(A) (JTAG:ISP)
AVRATmega168P_XPm	Atmel AVR ATmega168P(A) (USB, XPmini)
AVRATmega168PB_ISP	Atmel AVR ATmega168PB (JTAG:ISP)
AVRATmega168PB_XPm	Atmel AVR ATmega168PB (USB, XPmini)
CC1352	TI CC1352 RFSoC
DA14580	Dialog DA14580 RFSoC
ESP32	Espressif ESP32 RFSoC (JTAG)
ESP32_JTAG	Espressif ESP32 RFSoC (JTAG)
ESP32_UART	Espressif ESP32 RFSoC (UART)
LPC11xx	NXP LPC11xx MCU (SWD)
nRF52	Nordic nRF52 RFSoC (SWD)
nRF52_JLink	Nordic nRF52 RFSoC (USB, JLink)
nRF91	Nordic nRF9160 RFSoC:Cortex-M33 (SWD)
nRF91_JLink	Nordic nRF9160 RFSoC:Cortex-M33 (USB, JLink)
STM32F2	ST STM32F2xx MCU (SWD)
STM32F2_STLink	ST STM32F2xx MCU (USB, ST-Link)
STM32F4	ST STM32F4xx MCU (SWD)

target	Description
STM32F4_STLink	ST STM32F4xx MCU (USB, ST-Link)
STM32L4	ST STM32L4xx MCU (SWD)
STM32L4_STLink	ST STM32L4xx MCU (USB, ST-Link)

Example: Erase STM32L4 on-board flash.

ident: ICT-T1 title: Erase

steps:

- command: erase STM32L4

1.2.10 eval - Evaluate Expression

Evaluate an expression.

eval <expression>

Argument	Description
expression	Expression to evaluate

Supported operators:

Operator	Description
+	Addition, concatenation
-	Subtraction, Negation
<i>-</i> /	Division
*	Multiplication
* *	Power
%	Modulo
&	Bitwise And
 	Bitwise Or
۸	Bitwise Xor
~	Bitwise Not
>>	Right shift
<<	Left shift
!	Inversion
&&	Logican And
11	Logican Or
?	Ternary True
: ??	Ternary False
??	Null coalescence
>	Greater than
<=	Less than or equal
>=	Greater than or equal
=~	Regex match
!~	Regex mismatch

Example:

```
title: "Eval"
suite:
- ident: E0
  title: Eval
  steps:
- command: define test "AC1D"
- command: eval "test != 'F00BAR'" # PASS
- command: eval "test == 'AC1D'" # PASS
- command: eval "test != 'AC1D'" # FAIL
```

1.2.11 extflash_write - Write Peripheral Flash

Write DUT periperal flash.

Usage:

extflash_write UART0|UART1 <filename>

Argument	Description
UARTO, UART1	Port for UART targets
filename	Firmware Element Filename

1.2.12 freq - Frequency Monitor Control

Set the channel to use for frequency measurements.

Usage:

freq 0|1

Argument	Description
0	Use CLK0
1	Use CLK1

Example: Measure CLK1 frequency

title: Measure frequency

suite:

- ident: ICT-T1

title: Measure CLK1 frequency

steps:

- command: freq 1

- command: sleepms 1000

- command: measure frequency 7.90-8.10MHz

1.2.13 ftdiCfg - Configure external FTDI

Configure an externally connected FTDI FT4232H module.

Usage:

ftdiCfg FTDI1 <target> [<UARTxx>][,<UARTxx>[,<UARTxx>]]]

Argument	Description
target	FTDI interface; only FTDI1 can be configured.
UARTxx	UART port to use for each FTDI port: UART2, UART3,, or _ to skip.

1.2.14 identify - Identify DUT

Identify DUT MCU and/or RF peripherals.

identify <target> [UART0|UART1]

Argument	Description
target	Target to identify
UARTO, UART1	Port for UART targets

Supported target values:

target	Description
AVRATmega168P_ISP	Atmel AVR ATmega168P(A) (JTAG:ISP)
AVRATmega168P_XPm	Atmel AVR ATmega168P(A) (USB, XPmini)
AVRATmega168PB_ISP	Atmel AVR ATmega168PB (JTAG:ISP)
AVRATmega168PB_XPm	Atmel AVR ATmega168PB (USB, XPmini)
CC1352	TI CC1352 RFSoC
DA14580	Dialog DA14580 RFSoC
ESP32	Espressif ESP32 RFSoC (JTAG)
ESP32_JTAG	Espressif ESP32 RFSoC (JTAG)
ESP32_UART	Espressif ESP32 RFSoC (UART)
nRF52	Nordic nRF52 RFSoC (SWD)
nRF52_JLink	Nordic nRF52 RFSoC (USB, JLink)
nRF91	Nordic nRF9160 RFSoC:Cortex-M33 (SWD)
nRF91_JLink	Nordic nRF9160 RFSoC:Cortex-M33 (USB, JLink)
STM32F2	ST STM32F2xx MCU (SWD)
STM32F2_STLink	ST STM32F2xx MCU (USB, ST-Link)
STM32F4	ST STM32F4xx MCU (SWD)
STM32F4_STLink	ST STM32F4xx MCU (USB, ST-Link)
STM32L4	ST STM32L4xx MCU (SWD)
STM32L4_STLink	ST STM32L4xx MCU (USB, ST-Link)

1.2.15 image - Set background image

Usage:

image set <filename>
image clear

Argument	Description
set	Set background image
clear	Clear background image
filename	Filename of the PNG or JPEG element to show

Example: Background for operator test

title: "OLED Image"

suite:

- ident: ICT-T1 title: Show image

steps:

command: image set fighter.pngcommand: operator "Manual test"

1.2.16 label - Set Label Substitutions

Usage:

```
label keys <key> [<key>...]
```

The label command defines additional keys to substitute in the ZPL sent to the barcode printer, in addition to the default substitution keys.

Key	Description
DUT_PRODUCT	Product name
DUT_VERSION	Version
DUT_SERIAL	DUT Serial number
MAC_ADDRESS	MAC address
BLEMAC	BLE MAC address
FAILURE_MSG	Test failure

Example: Substitute CODE

title: "Custom barcode substitution"

suite:

- ident: ICT-T0

title: Define label keys

- command: define CODE 12345 - command: label keys CODE

The default ZPL generated by the PLT upon completion of a YAML test plan specification can be overridden by uploading template-pass.zpl and template-fail.zpl elements as part of the Release deployed through PLTcloud.

```
^FX template-fail.zpl - ZPL Template for failing DUTs
^XA^LH40,30
^MD2
^F00,10^ADN,30,8^FDC0DE^FS
^F00,80^ADN,30,8^FDN/G^FS
```

```
^FX template-pass.zpl - ZPL Template for DUTs that pass testing
^XA
~SD22
^CF0,30
^F040, 20^FDProduct: DUT_PRODUCT^FS
^F040,30^FDVersion:DUT_VERSION^FS
^F040,40^FDS/N:DUT_SERIAL^FS
^F040,50^FDMAC Address:MAC_ADDRESS^FS
^F040,60^FDBLE Address:BLEMAC^FS
```

^F040,70^FDFailure:FAILURE_MSG^FS ^F040,80^FDCode:CODE^FS

^F040,170^BY2 ^BCN, 50, N, N, N ^FDMAC_ADDRESS^FS

1.2.17 measure - Probe Measurement

Usage:

measure <channel> [<signal>] <range> [<reference>]

Argument	Description
channel	Measurement channel
signal	DDTPxx or RDTPxx probe for pin measurement

Argument	Description
range	Acceptable range
reference	Reference value

The **measure** command supports the following channels:

channel	Description
current3V3	3V3 current draw
current5V	5V current draw
currentVARV	VARV current draw
frequency	Frequency (CLKO or CLK1)
impedance	Impedance measurement (RVREF/RA)
pin	Digital pin measurement (DDTPxx/RDTPxx)
voltageDATP07	DATP07 voltage
voltageDATP08	DATP08 voltage
voltageDATP09	DATP09 voltage
voltageDATP10	DATP10 voltage
voltageDATP11	DATP11 voltage
voltageDATP12	DATP12 voltage
voltageMUX0	MUX0 voltage
voltageMUX1	MUX1 voltage
voltageMUX2	MUX2 voltage
voltageMUX3	MUX3 voltage

Example: Electrical measurements

```
title: Electrical measurements
suite:
- ident: ICT-T1
  title: Measure CLKO frequency
  - command: freq 0
  - command: sleepms 1000
  - command: measure frequency 32.75-32.78kHz
 ident: ICT-T2
  title: Measure Impedance
  steps:
  - command: mux 0 RATP02
  - command: mux 1 RATP03
  - command: mux 2 RA
  - command: mux 3 RVREF
  - command: short 0 2 set
  - command: short 1 3 set
  - command: measure impedance 750-1000m0hm 3.3V
  - command: short 0 2 release
   command: short 1 3 release
  - command: sleepms 1500
   command: measure impedance 2-100hm 3300
 ident: ICT-T3
  title: Measure Currents
  steps:
   command: measure current3V3 <1A
   command: measure current5V 0.1-0.5A
   command: measure currentVARV >100mA
 ident: ICT-T4
  title: Measure Voltages
  steps:

    command: mux 0 DATP00

  - command: mux 1 DATP01
  - command: mux 2 RATP00
  - command: mux 3 RATP17
  - command: measure voltageMUX0 >1V
   command: measure voltageMUX1 <3300mV
   command: measure voltageMUX2 >100mV
   command: measure voltageMUX3 1500-1800mV
   command: measure voltageDATP07 200-6000mV
   command: measure voltageDATP08 -0.2-0.1V
   command: measure voltageDATP09 0-4V
   command: measure voltageDATP10 -0.1-3.3V
   command: measure voltageDATP11 0-3.4V
  - command: measure voltageDATP12 -0.1-3.4V
```

Example: Digital pin measurement

```
title: Digital pin measurements
suite:
- ident: ICT-T1
  title: Configure Digital pins as inputs
steps:
- command: pin RDTP21 input pullup
- command: pin DDTP04 input
- ident: ICT-T2
  title: Read Digital pins
  steps:
- command: measure pin RDTP21 low
- command: measure pin DDTP04 high
```

1.2.18 mux - Multiplex Control

Select a probe or signal for a multiplex channel.

Usage:

```
mux <channel> <signal>
```

Argument	Description
channel	Multiplex channel (03)
signal	Probe or signal

The following signals and probes can be assigned to a multiplex channel:

signal	MUX	Description
DATP00DATP06	0, 1	Direct Analog Test Probes
RATP00RATP31	0, 1	Routed Analog Test Probes
DDTP00DDTP08	2,3	Direct Digital Test Probes
RVREF	all	Impedance measurement, reference voltage
RA	all	Impedance measurement, test voltage
GND	all	Ground
3V30UT	all	3.3V power rail
5V0UT	all	5.0V power rail
VARVDIV	all	VARV power rail, after 1/3 voltage divider

Example: Multiplex control

title: Multiplex control example

suite:

- ident: ICT-T1 title: Setup MUX

steps:

command: mux 0 DATP02
command: mux 1 DATP03
command: mux 2 RA
command: mux 3 RVREF
command: short 0 2 set
command: short 1 3 set

- ident: ICT-T2

title: Measure impedance DATP02..DATP03

steps:

- command: measure impedance 10-200kOhm

1.2.19 nfc - NFC Handling

Manipulate NFC cards.

Usage:

nfc write <TAGTYPE> <payload>...

Argument	Description
tagtype	Tag type (NTAG203, NTAG213 or NTAG216)
payload	NDEF payload (text:)

Example: Program NDEF message with two text records.

- ident: ICT-T1
 title: Write NFC

steps:

- command: define CODE 123

- command: nfc write NTAG213 text:"Sample Text" text:%CODE%

1.2.20 operator - Operator Test

Instruct operator to perform a manual test step.

Usage:

operator <message>

Example: Instruct operator to inspect housing.

- ident: ICT-T1

title: Visual Inspection (manual)

steps:

- command: operator "Inspect Housing"

1.2.21 pin - Digital pin control

Configure a Digital probe.

Usage:

```
pin probe> input [pullup]
pin probe> output [low|high]
```

Argument	Description
probe	Probe (DDTPxx, RDTPxx, UARTx_RTS or SWD_NRST)
input	Configure as input
pullup	Enable pull-up (only for RDTPxx pins)
output	Configure as output
low	Set low
high	Set high

Example: Control digital pins

title: Control digital pins

suite:

- ident: ICT-T1

title: Configure digital inputs

steps:

- command: pin DDTP05 input - command: pin DDTP03 input

- command: pin RDTP04 input pullup

- ident: ICT-T2

title: Control digital outputs

steps:

command: pin DDTP00 output high
 command: pin DDTP02 output low
 command: pin RDTP01 output high
 command: pin SWD_NRST output low
 command: pin UART1_RTS output high

1.2.22 power - Power Control

Control power applied to the Device Under Test.

Usage:

```
power off
power <rail> [on|off|<level>]
```

Argument	Description
rail	Power rail
on	Turn on the specified power rail
off	Turn off all or specified power rail
level	Voltage level for VARV: 212.0

Supported rail values:

rail	Description
3V3	3.3V power rail
5V	5V power rail
VARV	Variable power rail
12V	12V power rail
SWD	SWD (3.3V) power rail
JTAG	JTAG (3.3V) power rail
UART0	UARTO (3.3V) power rail
UART1	UART1 (3.3V) power rail

Example: Apply power

title: Power control example

suite:

ident: ICT-T1 title: Apply power

steps:

command: power 3V3 oncommand: power 5V oncommand: power VARV 10.2

- ident: ICT-T2 title: Wait

steps:

- command: sleepms 1000

- ident: ICT-T3
 title: Power off

steps:

- command: power off

1.2.23 program - Program DUT

Erase and Program DUT MCU on-board flash.

Usage:

program <target> [UART0|UART1] [offset:][,[offset:][,...]] [noerase]

Argument	Description
target	Target to program
UARTO, UART1	Port for UART targets
offset	Optional: Offset image
img	Firmware Element
	Optional: Additional offsets, images

Firmware images can be provided as Intel HEX (.hex), ELF (.elf/.axf) or binary files (requiring an offset).

Supported target values:

target	Description
AVRATmega168P_ISP	Atmel AVR ATmega168P(A) (JTAG:ISP)
AVRATmega168P_XPm	Atmel AVR ATmega168P(A) (USB, XPmini)
AVRATmega168PB_ISP	Atmel AVR ATmega168PB (JTAG:ISP)
AVRATmega168PB_XPm	Atmel AVR ATmega168PB (USB, XPmini)
CC1352	TI CC1352 RFSoC

target	Description
DA14580	Dialog DA14580 RFSoC
ESP32	Espressif ESP32 RFSoC (JTAG)
ESP32_JTAG	Espressif ESP32 RFSoC (JTAG)
ESP32_UART	Espressif ESP32 RFSoC (UART)
LPC11xx	NXP LPC11xx MCU (SWD)
nRF52	Nordic nRF52 RFSoC (SWD)
nRF52_JLink	Nordic nRF52 RFSoC (USB, JLink)
nRF91	Nordic nRF9160 RFSoC:Cortex-M33 (SWD)
nRF91_JLink	Nordic nRF9160 RFSoC:Cortex-M33 (USB, JLink)
PN7360	NXP PN7360 (SWD)
PN7362	NXP PN7362 (SWD)
PN7460	NXP PN7460 (SWD)
PN7462	NXP PN7462 (SWD)
STM32F2	ST STM32F2xx MCU (SWD)
STM32F2_STLink	ST STM32F2xx MCU (USB, ST-Link)
STM32F4	ST STM32F4xx MCU (SWD)
STM32F4_STLink	ST STM32F4xx MCU (USB, ST-Link)
STM32L4	ST STM32L4xx MCU (SWD)
STM32L4_STLink	ST STM32L4xx MCU (USB, ST-Link)

1.2.24 scan - Scan Barcode

Scan a barcode using USB-attached barcode scanner.

Usage:

scan <format>

Argument	Description
format	Format of code to scan

Supported *format* values:

format	Description
ANY	Any barcode
%MAC_ADDRESS%	48-bit MAC address (XX:XX:XX:XX:XX)

title: Scan serial number

suite:
- steps:

command: scan ANY extractKey: MY_BARCODE

- command: serial set %MY_BARCODE%

1.2.25 serial - Request or set serial number

Set serial number, from test plan or through PLTcloud.

Under Project Settings in PLTcloud, serial number allocation can be configured to use either monotonic counters, or through a webhook.

Usage:

```
serial request [<KEY>:<jsonKey>]...
serial set <value>
```

Argument	Description
request	Request serial number through PLTcloud backend
KEY	Test plan user key to extract from webhook response
jsonKey	Webhook response "extra" map key
set	Request serial number through PLTcloud backend

When using serial request, and a webhook is selected in PLTcloud, a JSON request will be sent containing:

```
{
   "dut_id": "<DUT IDENTIFIER>",
   "serial_number": "<SERIAL NUMBER>",
   "ble_mac": "<BLE MAC>",
   "mcu_id": "<MCU ID>",
   "MYCUSTOMKEY": "my custom value"
}
```

The API endpoint should return something like:

```
{
    "serial_number": "<SERIAL NUMBER>",
    "extra": {
        "name": "Ben"
    }
}
```

To extract the name field, use the serial request command as below:

```
title: Eventbrite
suite:
· ident: SCAN
  title: Scan
  steps:
  - command: scan ANY
    extractKey: BARCODE
 ident: WEBHOOK
  title: Lookup barcode
  steps:
  - command: serial request NAME:name
  - command: operator %NAME%
- ident: PRINT
  title: Print badge
  steps:
  - command: label keys NAME
```

Using serial set, the serial number can be set directly from the test plan, for example using a key extracted from a barcode scan:

```
title: Scan serial number
suite:
- steps:
- command: scan ANY
    extractKey: BARCODE
- command: serial set %BARCODE%
```

1.2.26 short - Connect Multiplex channels

Usage:

short <muxA> <muxB> set|release

Argument Description	
----------------------	--

Argument	Description
muxA	Multiplex channel (03)
тихВ	Multiplex channel (03)
set	Short specified multiplex channels
release	Release short between specified multiplex channels

Example: connect multiplex channels

title: Multiplex example

suite:

- ident: ICT-T1

title: Control shorts

steps:

command: short 0 1 setcommand: short 1 3 setcommand: sleepms 1000

- ident: ICT-T1

title: 0-2 instead of 0-1

steps:

- command: short 0 1 release - command: short 0 2 set

1.2.27 sleepms - Delay

Temporarily suspend test suite execution.

Usage:

sleepms <duration>

Argument	Description
duration	Duration, in milliseconds

1.2.28 uart - Send and Extract UART response

Extract data from UART.

Usage:

uartcmd: uart UART0|UART1 [noflush]

[[expect: <expectText>]
 [extract: <extractText>

extractKey: <extractKey>...]]

[send: <sendText>]

Argument	Description
UARTO, UART1	UART port
expectText	Text to expect, prior to extraction
extractText	Regular expression to extract
extractKey	Key(s) in which to store extracted text
sendText	Text to send prior to extaction
noflush	Don't flush receive buffer before extraction

Example: extract ICCID from cellular modem, storing in the ICCID key.

- uartcmd: uart UART0
 expect: "+CCID:"

extract: "CCID: (\\d{20})\r\n"

extractKey: ICCID
send: "AT+ICCID\r\n"

1.2.29 uartAwait - Await UART response

Wait for a specific UART response.

Usage:

uartAwait UART0|UART1 <seconds>

Argument	Description
UARTO, UART1	UART port
seconds	Time to await response, in seconds

Example:

command: uartExpect UARTO Pressedcommand: operator "Press button"

- command: uartAwait UART0 1

1.2.30 uartCfg - Configure UART

Configure a UART port.

Usage:

uartCfg UART0|UART1 <speed> [<triplet>]
uartCfg UART0 tp

Argument	Description
UARTO, UART1	UART port
speed	Baud rate
triplet	UART configuration triplet: 8N1 or 7E1
tp	Use alternate test points instead of UART. (Only for UART0)

Example:

- command: uartCfg UART1 9600 8N1

- command: uartCfg UART0 tp

1.2.31 uartExpect - Set expectation for uartAwait

Set a UART response to wait for with the uartAwait command.

Usage:

uartExpect UART0|UART1 <expect> [noflush]

Argument	Description
UARTO, UART1	UART port
expect	String to expect with subsequent uartAwait command
noflush	Don't flush receive buffer before extraction

Example:

command: uartExpect UARTO Pressedcommand: operator "Press button"

- command: uartAwait UARTO 1

1.2.32 uartReadTimeout - Test if UART is not transmitting

Test if nothing is received from UART.

Usage:

uartReadTimeout UART0|UART1 <seconds> [<sendText>]

Argument	Description
UARTO, UART1	UART port
seconds	Number of seconds to wait for incoming data
sendText	Text to send before waiting

Example: Test if modem is shut down.

- command: uartReadTimeout UART0 1 "AT"